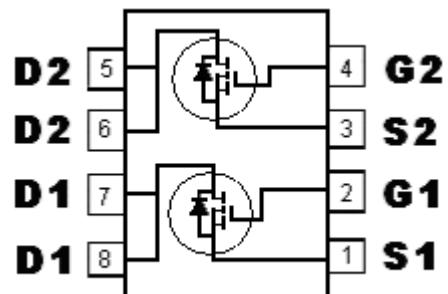
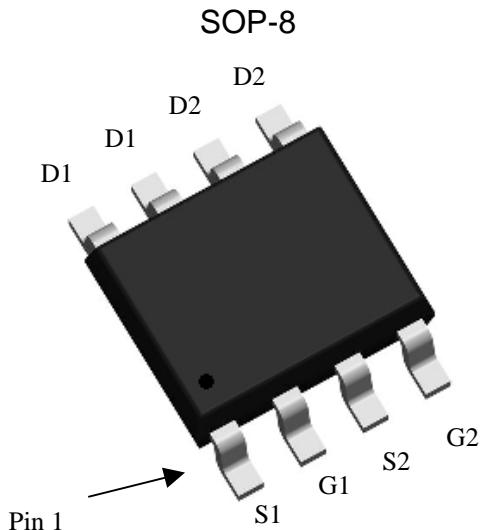


## Dual P-Channel Logic Level Enhancement Mode Power MOSFET

### Features:

- $R_{DS(ON)}=24\text{m}\Omega(\text{max.})$  @  $V_{GS}=-10\text{V}$ ,  $I_D=-8\text{A}$
- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Dual P-ch MOSFET package
- Pb-free lead plating & Halogen-free package



G : Gate D : Drain S : Source

$BV_{DSS}$	-30V
$I_D$ @ $V_{GS}=-10\text{V}$ , $T_c=25\text{ }^\circ\text{C}$	-8A
$R_{DS(on)}(\text{MAX})$ @ $V_{GS}=-10\text{V}$ , $I_D=-8\text{A}$	18m $\Omega$ (typ.)
$R_{DS(on)}(\text{MAX})$ @ $V_{GS}=-4.5\text{V}$ , $I_D=-6\text{A}$	27m $\Omega$ (typ.)

### Ordering Information

Device	Package	Shipping
KSCB24B03	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / tape & reel

## Absolute Maximum Ratings ( $T_a=25^\circ C$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	-30	<b>V</b>
Gate-Source Voltage	$V_{GS}$	$\pm 25$	
Continuous Drain Current, $V_{GS}=-10V$ , $T_c=25^\circ C$	$I_D$	-8	<b>A</b>
Continuous Drain Current, $V_{GS}=-10V$ , $T_c=100^\circ C$		-6	
Pulsed Drain Current (Note 1)	$I_{DM}$	-32	
Avalanche Current	$I_{AS}$	-12	
Avalanche Energy @ $L=1mH$ , $I_D=-8A$ , $R_G=25\Omega$	$E_{AS}$	32	<b>mJ</b>
Repetitive Avalanche Energy @ $L=0.05mH$ *2	$E_{AR}$	8	
Power Dissipation	$P_D$	2.4	<b>W</b>
		1.3	
Operating Junction and Storage Temperature Range	$T_j$ ; $T_{stg}$	-55~+175	$^\circ C$

100% UIS testing in condition of  $V_D=-15V$ ,  $L=0.1mH$ ,  $V_G=-10V$ ,  $I_L=-8A$ , Rated  $V_{DS}=-30V$  P-CH

## Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{th,j-c}$	25	$^\circ C/W$
Thermal Resistance, Junction-to-ambient, max	$R_{th,j-a}$	62.5 *3	

Note : 1. Pulse width limited by maximum junction temperature  
 2. Duty cycle  $\leq 1\%$   
 3. Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, 125°C/W when mounted on minimum copper pad

## Characteristics ( $T_j=25^\circ C$ , unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
$BV_{DSS}$	-30	-	-	<b>V</b>	$V_{GS}=0V$ , $I_D=-250\mu A$
$V_{GS(th)}$	-1	-1.5	-2.5		$V_{DS} = V_{GS}$ , $I_D=-250\mu A$
$I_{GSS}$	-	-	$\pm 100$	$nA$	$V_{GS}=\pm 25V$
$ID_{SS}$	-	-	-1	$\mu A$	$V_{DS}=-24V$ , $V_{GS}=0V$
	-	-	-10		$V_{DS}=-20V$ , $V_{GS}=0V$ , $T_j=125^\circ C$
$I_{D(ON)} *1$	-8	-	-	$A$	$V_{DS}=-5V$ , $V_{GS}=-10V$
$*R_{DS(ON)} *1$	-	18	24	$m\Omega$	$V_{GS}=-10V$ , $I_D=-8A$
	-	27	30		$V_{GS}=-4.5V$ , $I_D=-6A$
$G_{FS} *1$	-	13	-	$S$	$V_{DS}=-5V$ , $I_D=-8A$
<b>Dynamic</b>					
$Q_g(V_{GS}=-10V) *1, 2$	-	24	-	$nC$	$I_D=-8A$ , $V_{DS}=-15V$ , $V_{GS}=-10V$
$Q_g(V_{GS}=-5V) *1, 2$	-	16.1	-		
$Q_{gs} *1, 2$	-	6.8	-		
$Q_{gd} *1, 2$	-	8	-		

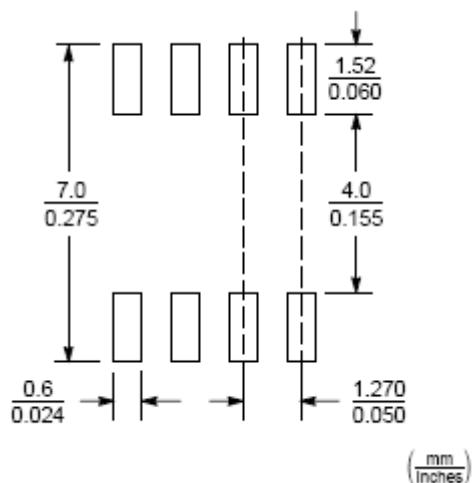
td(ON) *1, 2	-	9.3	-	ns	V <sub>DS</sub> =-15V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V, R <sub>G</sub> =2.7Ω
tr *1, 2	-	6.1	-		
td(OFF) *1, 2	-	27	-		
tf *1, 2	-	8	-		
C <sub>iss</sub>	-	2006	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz
C <sub>oss</sub>	-	200	-		
C <sub>rss</sub>	-	153	-		
R <sub>g</sub>	-	4	-		
<b>Source-Drain Diode</b>					
I <sub>S</sub> *1	-	-	-2.3	A	
I <sub>SM</sub> *3	-	-	-9.2		
V <sub>SD</sub> *1	-	-	-1.2	V	I <sub>F</sub> = I <sub>S</sub> , V <sub>GS</sub> =0V
t <sub>rr</sub> *1	-	32	-	ns	I <sub>F</sub> = I <sub>S</sub> , dI <sub>F</sub> /dt=100A/μs
Q <sub>rr</sub> *1	-	26	-	nC	

Note : \*1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

\*2.Independent of operating temperature

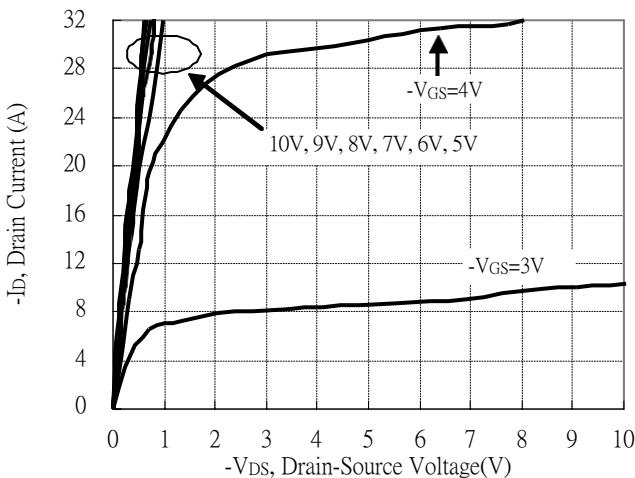
\*3.Pulse width limited by maximum junction temperature.

## Recommended Soldering Footprint

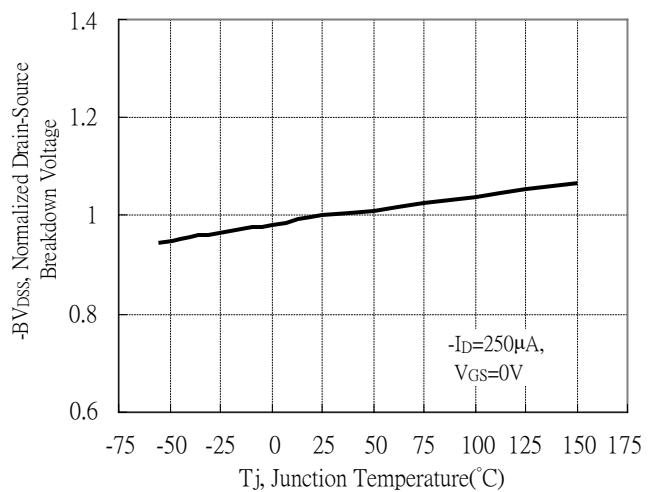


## Typical Characteristics

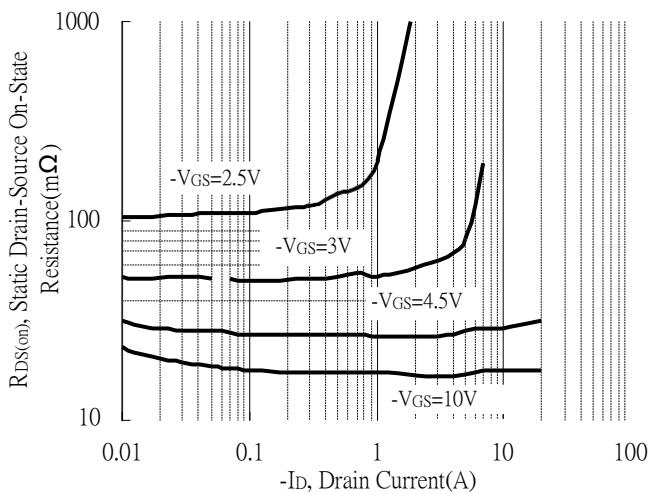
Typical Output Characteristics



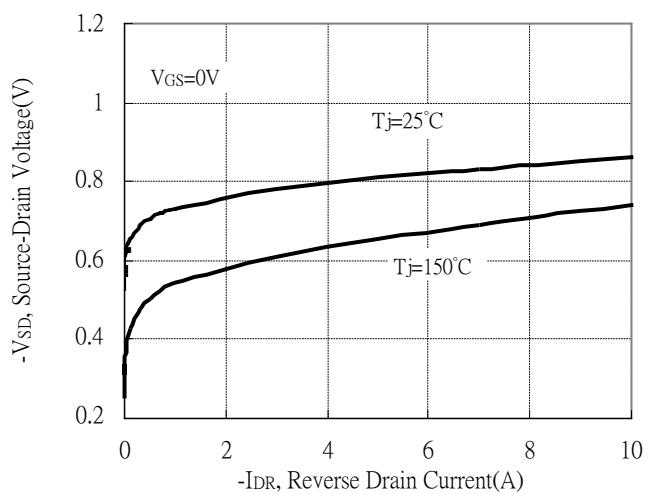
Breakdown Voltage vs Ambient Temperature



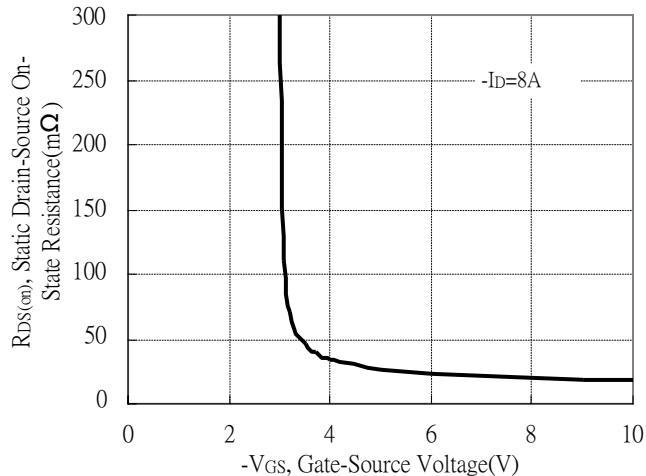
Static Drain-Source On-State resistance vs Drain Current



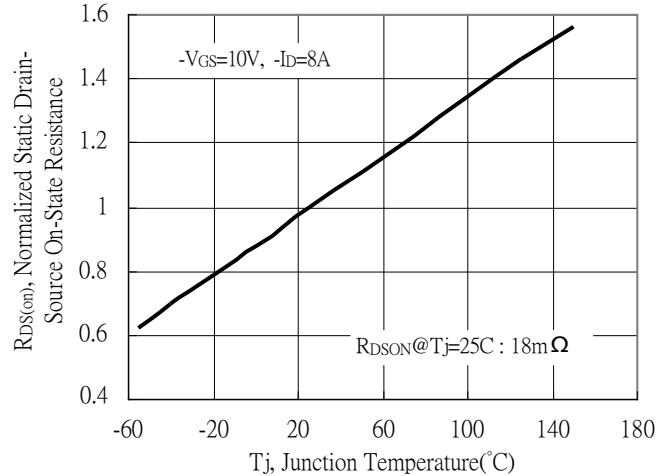
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

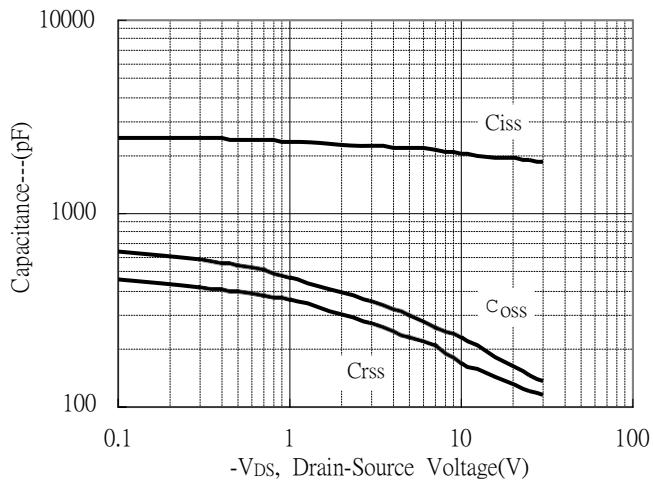


Drain-Source On-State Resistance vs Junction Temperature

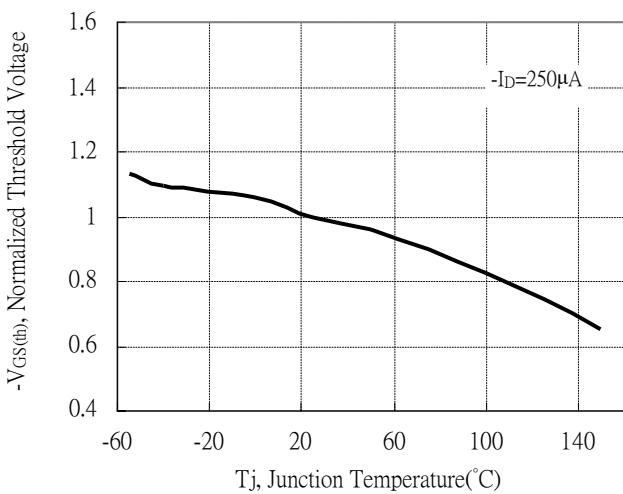


## Typical Characteristics(Cont.)

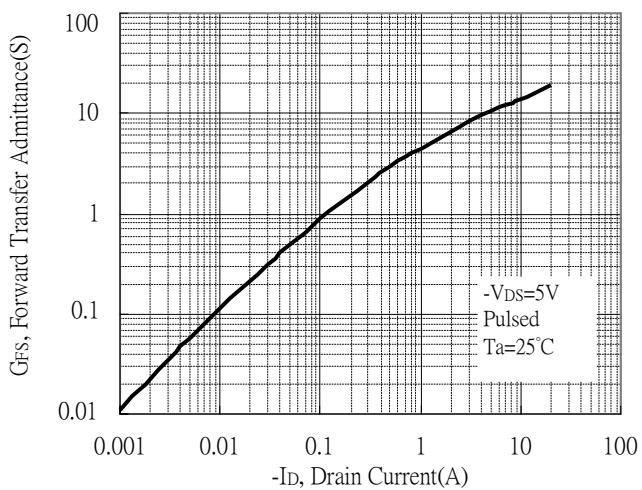
Capacitance vs Drain-to-Source Voltage



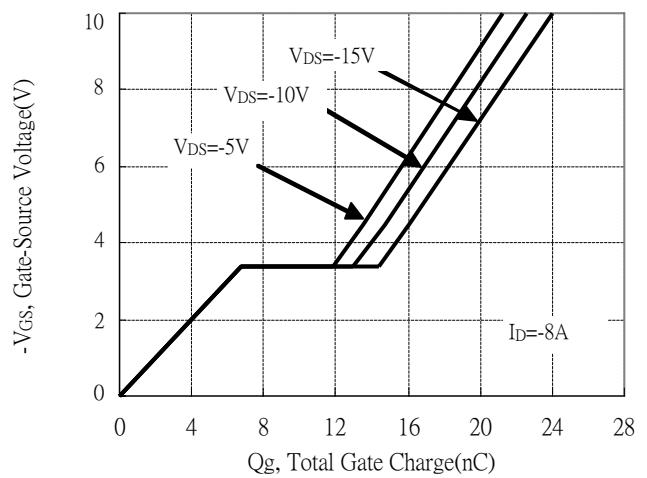
Threshold Voltage vs Junction Temperature



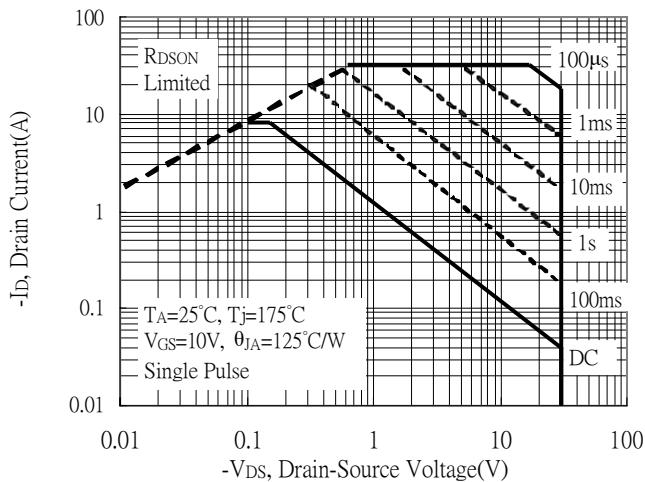
Forward Transfer Admittance vs Drain Current



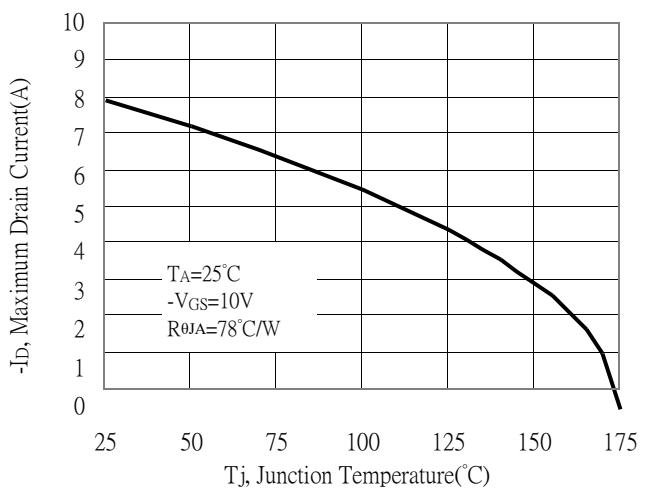
Gate Charge Characteristics



Maximum Safe Operating Area

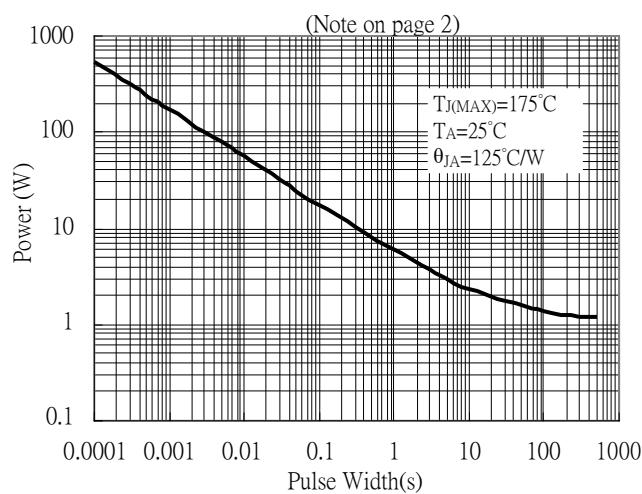


Maximum Drain Current vs Junction Temperature

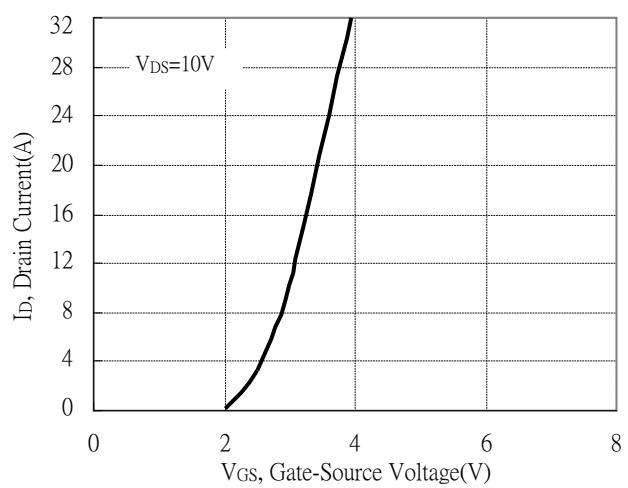


## Typical Characteristics(Cont.)

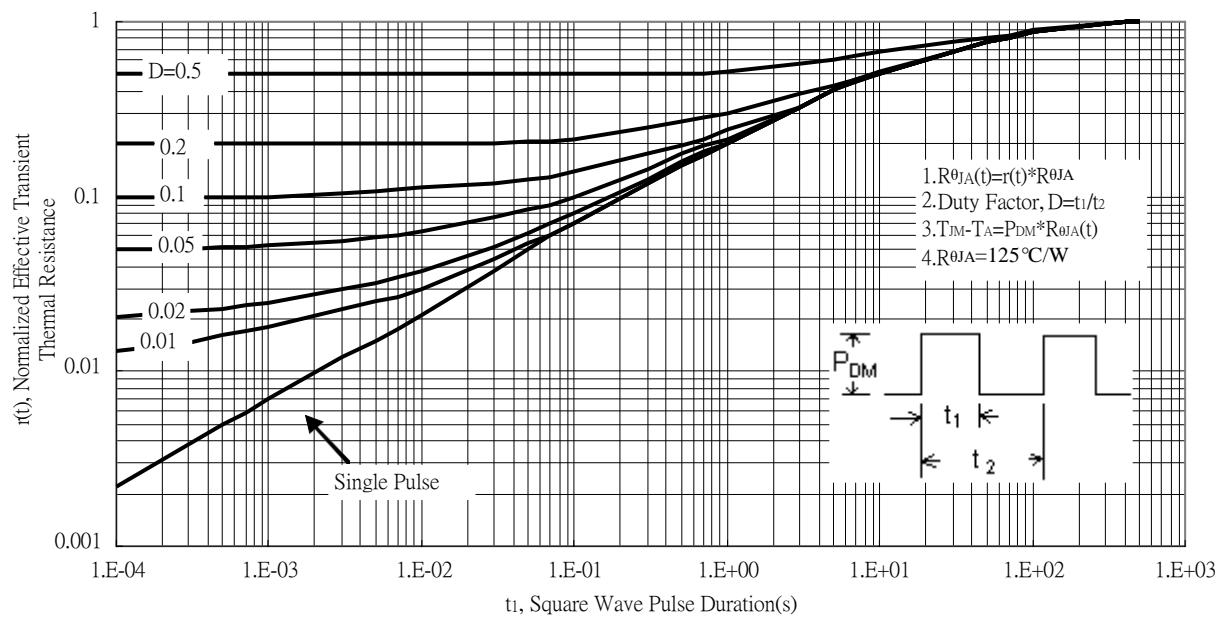
Single Pulse Power Rating, Junction to Ambient



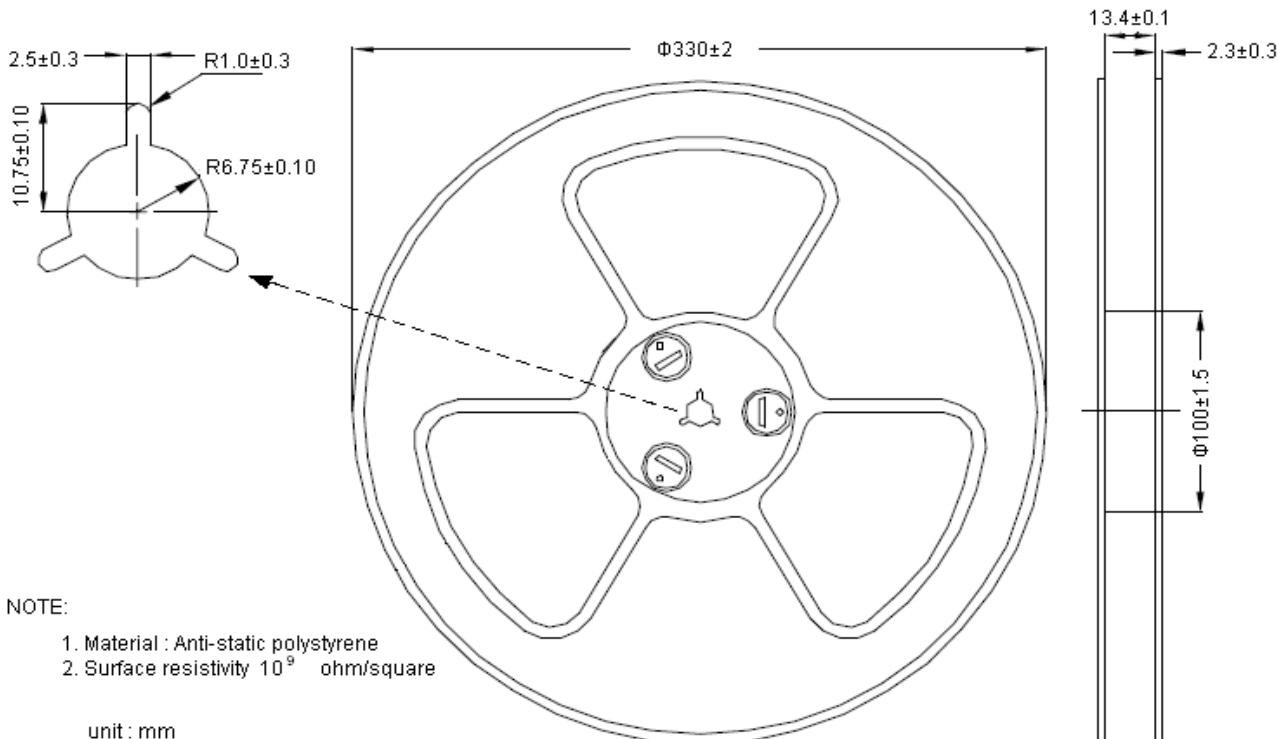
Typical Transfer Characteristics



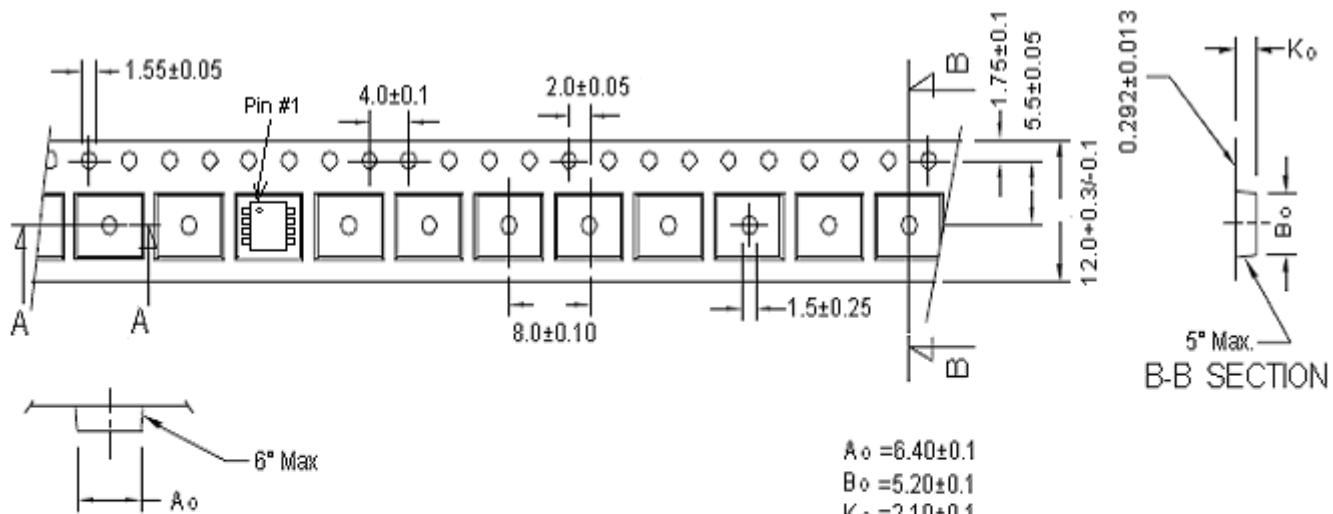
Transient Thermal Response Curves



## Reel Dimension



## Carrier Tape Dimension



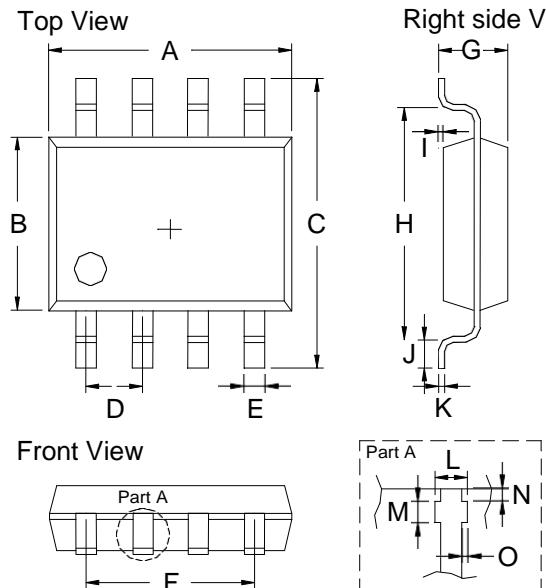
### A-A SECTION

Notes:

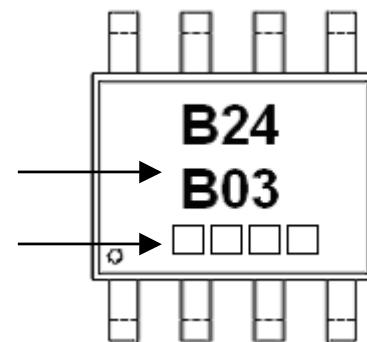
1. 10 sprocket hole pitch cumulative tolerance  $\pm 0.2$ .
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene
4. A<sub>o</sub> & B<sub>o</sub> measured on a plane 0.3mm above the bottom of the pocket.
5. K<sub>o</sub> measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Uni : millimeter

## SOP-8 Dimension



Marking:



8-Lead SOP-8 Plastic Package

\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1890	0.2007	4.80	5.10	I	0.0098	REF	0.25	REF
B	0.1496	0.1654	3.80	4.20	J	0.0118	0.0354	0.30	0.90
C	0.2283	0.2441	5.80	6.20	K	0.0074	0.0098	0.19	0.25
D	0.0480	0.0519	1.22	1.32	L	0.0145	0.0204	0.37	0.52
E	0.0138	0.0193	0.35	0.49	M	0.0118	0.0197	0.30	0.50
F	0.1472	0.1527	3.74	3.88	N	0.0031	0.0051	0.08	0.13
G	0.0531	0.0689	1.35	1.75	O	0.0000	0.0059	0.00	0.15
H	0.1889	0.2007	4.80	5.10					